

PHP20N06T-VB Datasheet N-Channel 60 V(D-S) MOSFET

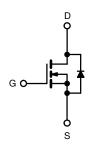
PRODUCT SUMMARY					
V _{DS} (V)	60				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.072			
Q _g max. (nC)	25				
Q _{gs} (nC)	5.8				
Q _{gd} (nC)	11				
Configuration	Single				

FEATURES

- Dynamic dV/dt rating
- Fast switching
- Ease of paralleling Simple drive requirements







ABSOLUTE MAXIMUM RATINGS (TC	= 25 °C, unl	less otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	60	V
Gate-Source Voltage			V_{GS}	± 20	¬
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		20	
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	12	Α
Pulsed Drain Current ^a			I _{DM}	68	
Linear Derating Factor				0.40	W/°C
Single Pulse Avalanche Energy b			E _{AS}	100	mJ
Maximum Power Dissipation	T _C =	25 °C	P_{D}	60	W
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	- °C
Soldering Recommendations (Peak temperature) ^d	for	10 s		300	7
Mounting Torque	6 22 or l	0.00 140		10	lbf ⋅ in
Mounting Torque	6-32 or M3 screw			1.1	N⋅m

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 403 \,\mu\text{H}$, $R_g = 25 \,\Omega$, $I_{AS} = 17 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le 17$ A, $dI/dt \le 140$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.5	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		1		<u> </u>			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.061	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	1.0	-	3.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$		-	25 250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A ^b	-	0.072	-	Ω
Forward Transconductance	9 _{fs}	V_{DS}	= 25 V, I _D = 10 A	5.5	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	640	-	
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$		360	-	рF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	79	-	
Total Gate Charge	Qg			-	-	25	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 17 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 b	-	-	5.8	nC
Gate-Drain Charge	Q _{gd}	1		-	-	11	
Turn-On Delay Time	t _{d(on)}		•	-	13	-	
Rise Time	t _r	V _{DD}	= 30 V, I _D = 17 A,	-	58	-	
Turn-Off Delay Time	t _{d(off)}		$R_D = 1.7 \Omega$, see fig. 10 b	-	25	-	ns
Fall Time	t _f			-	42		
Internal Drain Inductance	L _D	Between lead 6 mm (0.25")	from	-	4.5	-	-11
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s				•	I.	
Continuous Source-Drain Diode Current	I _S	MOSFET sym	bol	-	-	20	^
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction	\' \	-	-	68	A
Body Diode Voltage	V _{SD}	T _J = 25 °C	s, I _S = 17 A, V _{GS} = 0 V b	-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 00 1	47 A 41/4± 400 A / -	-	88	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}	T _J = 25 °C, 1	$_{F}$ = 17 A, dl/dt = 100 A/ μ s	-	0.29	0.64	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	v L _s and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%$.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

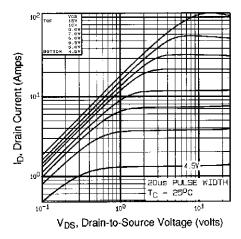


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

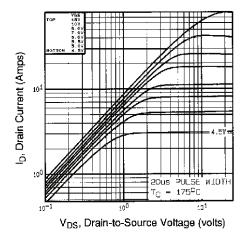


Fig. 2 - Typical Output Characteristics, T_C = 175 $^{\circ}C$

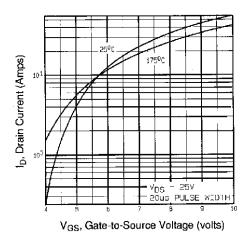


Fig. 3 - Typical Transfer Characteristics

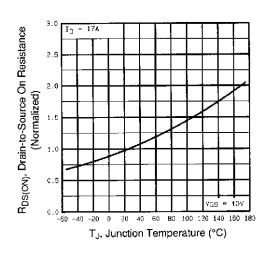


Fig. 4 - Normalized On-Resistance vs. Temperature

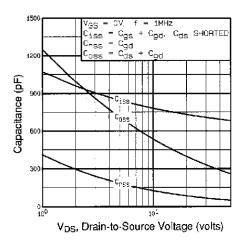


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

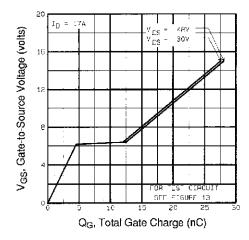


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



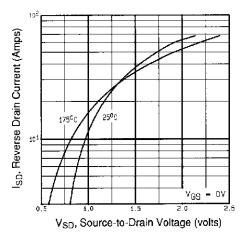


Fig. 7 - Typical Source-Drain Diode Forward Voltage

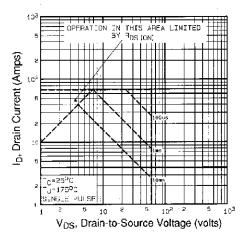


Fig. 8 - Maximum Safe Operating Area

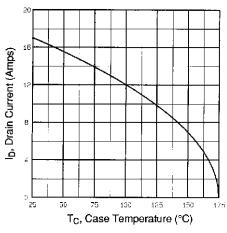


Fig. 9 - Maximum Drain Current vs. Case Temperature

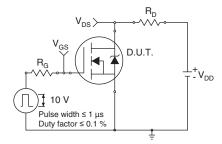


Fig. 10a - Switching Time Test Circuit

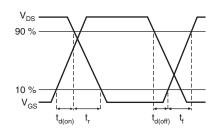


Fig. 10b - Switching Time Waveforms

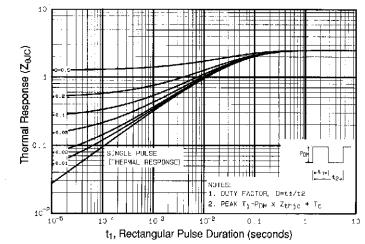
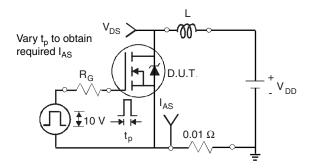


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





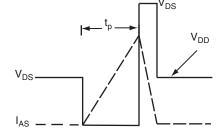


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

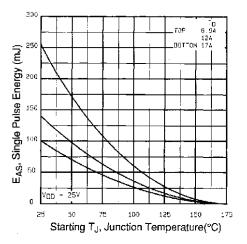


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

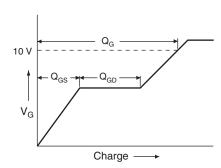


Fig. 13a - Basic Gate Charge Waveform

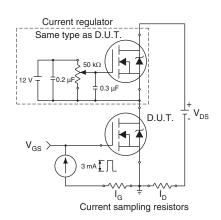
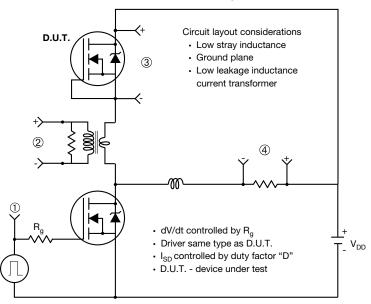


Fig. 13b - Gate Charge Test



Peak Diode Recovery dV/dt Test Circuit



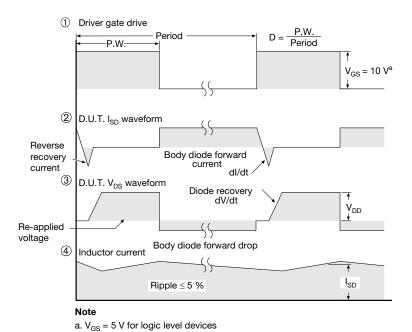
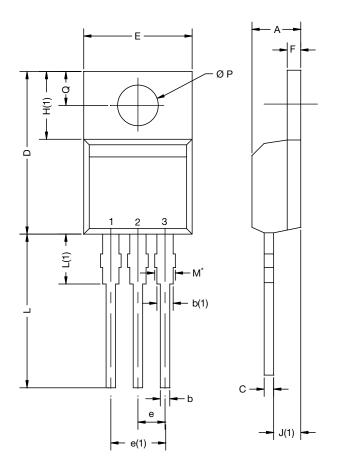


Fig. 14 - For N-Channel



TO-220



MIN. 4.24 0.69 1.14 0.36 14.33 9.96 2.41 4.88	MAX. 4.65 1.02 1.78 0.61 15.85 10.52 2.67	MIN. 0.167 0.027 0.045 0.014 0.564 0.392 0.095	MAX. 0.183 0.040 0.070 0.024 0.624 0.414 0.105
0.69 1.14 0.36 14.33 9.96 2.41	1.02 1.78 0.61 15.85 10.52	0.027 0.045 0.014 0.564 0.392	0.040 0.070 0.024 0.624 0.414
1.14 0.36 14.33 9.96 2.41	1.78 0.61 15.85 10.52	0.045 0.014 0.564 0.392	0.070 0.024 0.624 0.414
0.36 14.33 9.96 2.41	0.61 15.85 10.52	0.014 0.564 0.392	0.024 0.624 0.414
14.33 9.96 2.41	15.85 10.52	0.564 0.392	0.624 0.414
9.96 2.41	10.52	0.392	0.414
2.41			
	2.67	0.095	0.105
4 88			
1.00	5.28	0.192	0.208
1.14	1.40	0.045	0.055
6.10	6.71	0.240	0.264
2.41	2.92	0.095	0.115
13.36	14.40	0.526	0.567
3.33	4.04	0.131	0.159
3.53	3.94	0.139	0.155
2.54	3.00	0.100	0.118
	2.41 13.36 3.33 3.53 2.54	2.41 2.92 13.36 14.40 3.33 4.04 3.53 3.94	2.41 2.92 0.095 13.36 14.40 0.526 3.33 4.04 0.131 3.53 3.94 0.139 2.54 3.00 0.100

Note

 $\bullet~M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM

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